

N-Channel Enhancement Mode Power MOSFET

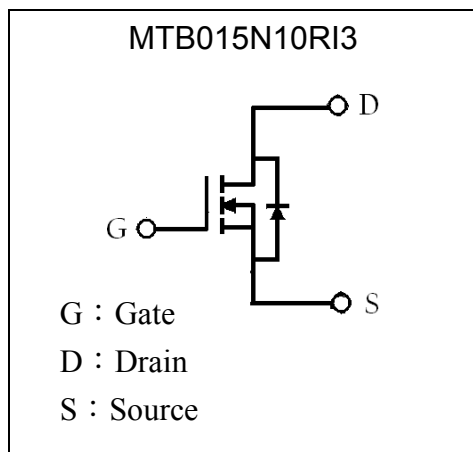
MTB015N10RI3

BV_{DSS}	100V
I_D@ V_{GS}=10V, T_C=25°C	46A
R_{DS(ON)}@ V_{GS}=10V, I_D=20A	13.5mΩ (typ)
R_{DS(ON)}@ V_{GS}=4.5V, I_D=20A	16.0mΩ (typ)

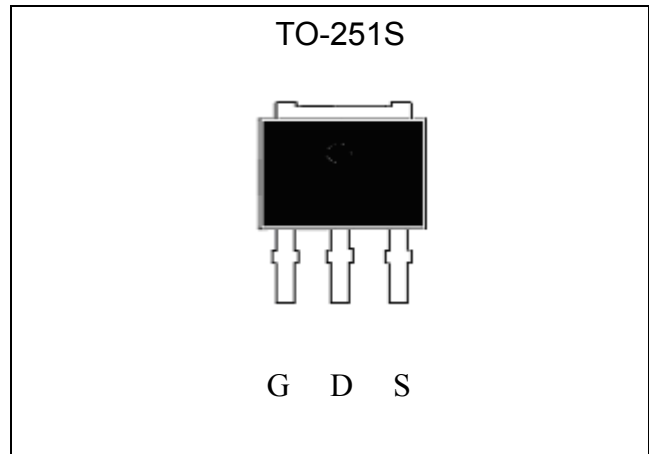
Features

- Simple Drive Requirement
- Repetitive Avalanche Rated
- Fast Switching Characteristic
- RoHS compliant package & Halogen-free package

Symbol

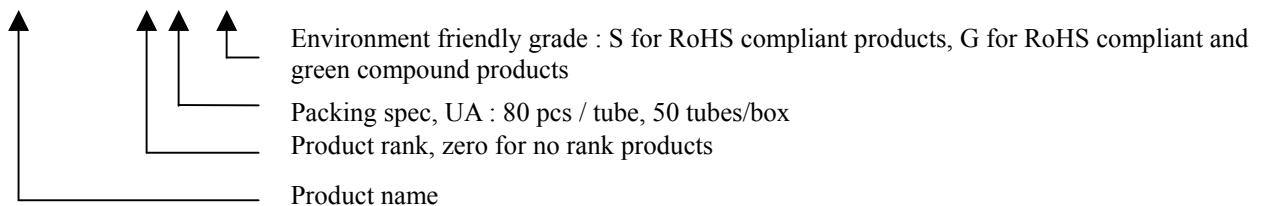


Outline



Ordering Information

Device	Package	Shipping
MTB015N10RI3-0-UA-G	TO-251S (RoHS compliant and halogen-free package)	80 pcs/tube, 50 tubes/box





Absolute Maximum Ratings ($T_c=25^{\circ}\text{C}$, unless otherwise noted)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current @ $V_{GS}=10\text{V}$, $T_c=25^{\circ}\text{C}$	I_D	46	A
Continuous Drain Current @ $V_{GS}=10\text{V}$, $T_c=100^{\circ}\text{C}$		29	
Pulsed Drain Current (Note 1)	I_{DM}	184	
Avalanche Current @ $L=0.1\text{mH}$	I_{AS}	46	mJ
Avalanche Energy @ $L=0.1\text{mH}$, $I_D=46\text{A}$, $R_G=25\ \Omega$ (Note 3)	E_{AS}	106	
Repetitive Avalanche Energy @ $L=0.05\text{mH}$ (Note 2)	E_{AR}	6	
Total Power Dissipation @ $T_c=25^{\circ}\text{C}$	P_D	62.5	W
Total Power Dissipation @ $T_c=100^{\circ}\text{C}$		25	
Operating Junction and Storage Temperature Range	T_j, T_{stg}	-55~+150	$^{\circ}\text{C}$

- Note : 1. Pulse width limited by maximum junction temperature.
 2. Duty cycle $\leq 1\%$.
 3. 100% tested by conditions of $L=0.1\text{mH}$, $V_{GS}=10\text{V}$, $I_{AS}=24\text{A}$, $V_{DD}=25\text{V}$

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	$R_{th,j-c}$	2	$^{\circ}\text{C}/\text{W}$
Thermal Resistance, Junction-to-ambient, max	$R_{th,j-a}$	110	

Characteristics ($T_c=25^{\circ}\text{C}$, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV_{DSS}	100	-	-	V	$V_{GS}=0\text{V}$, $I_D=250\ \mu\text{A}$
$V_{GS(th)}$	1	-	3		$V_{DS} = V_{GS}$, $I_D=250\ \mu\text{A}$
I_{GSS}	-	-	± 100	nA	$V_{GS}=\pm 20\text{V}$, $V_{DS}=0\text{V}$
I_{DSS}	-	-	1	μA	$V_{DS} = 80\text{V}$, $V_{GS} = 0\text{V}$
	-	-	25		$V_{DS} = 80\text{V}$, $V_{GS} = 0\text{V}$, $T_j=125^{\circ}\text{C}$
$*R_{DS(ON)}$	-	13.5	16.6	$\text{m}\Omega$	$V_{GS} = 10\text{V}$, $I_D=20\text{A}$
	-	16.0	22.5		$V_{GS} = 4.5\text{V}$, $I_D=20\text{A}$
$*G_{FS}$	-	32.2	-	S	$V_{DS} = 10\text{V}$, $I_D=20\text{A}$
Dynamic					
$*Q_g$	-	54.4	-	nC	$V_{DS}=80\text{V}$, $I_D=20\text{A}$, $V_{GS}=10\text{V}$
$*Q_{gs}$	-	7.7	-		
$*Q_{gd}$	-	10.7	-		
$*t_{d(ON)}$	-	16.6	-	ns	$V_{DS}=50\text{V}$, $I_D=20\text{A}$, $V_{GS}=10\text{V}$, $R_{GS}=1\ \Omega$
$*t_r$	-	18	-		
$*t_{d(OFF)}$	-	59.6	-		
$*t_f$	-	6.6	-		



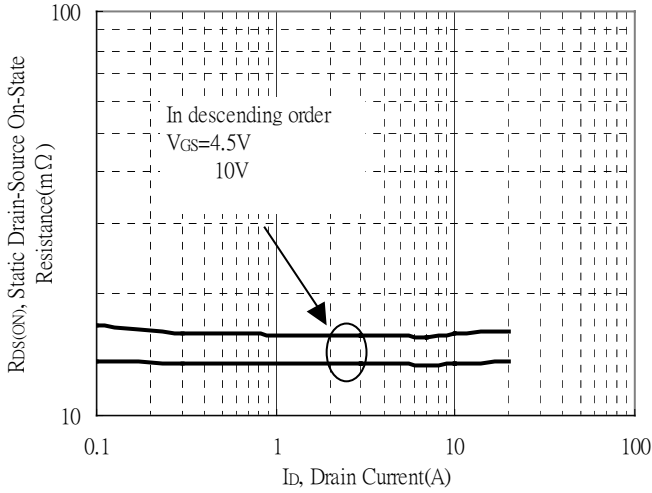
Ciss	-	2652	-	pF	V _{DS} =50V, V _{GS} =0V, f=1MHz
Coss	-	179	-		
Crss	-	18	-		
Rg	-	1	-	Ω	f=1MHz
Source-Drain Diode					
*I _S	-	-	46	A	
*I _{SM}	-	-	184		
*V _{SD}	-	0.85	1.2	V	I _S =20A, V _{GS} =0V
*trr	-	30	-	ns	I _F =20A, V _{GS} =0V, dI _F /dt=100A/μs
*Qrr	-	39	-	nC	

*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

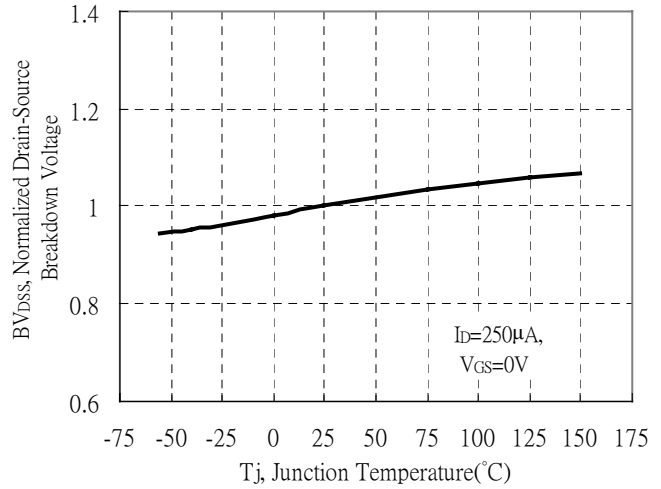


Typical Characteristics

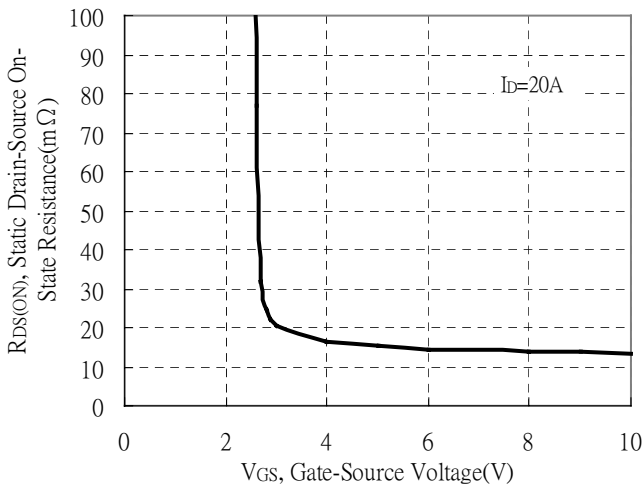
Static Drain-Source On-State resistance vs Drain Current



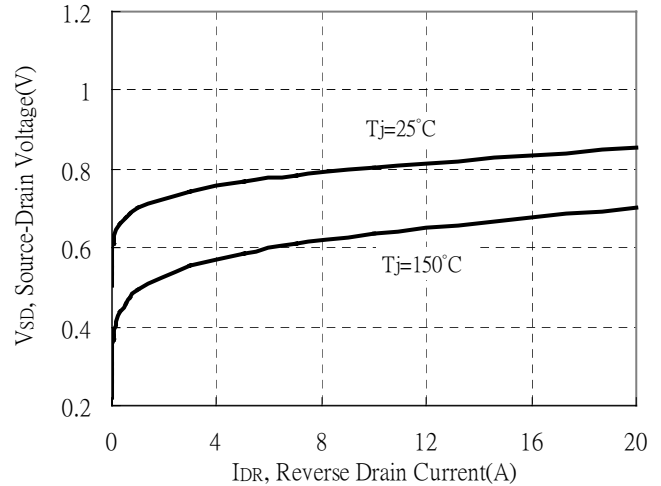
Brekdown Voltage vs Ambient Temperature



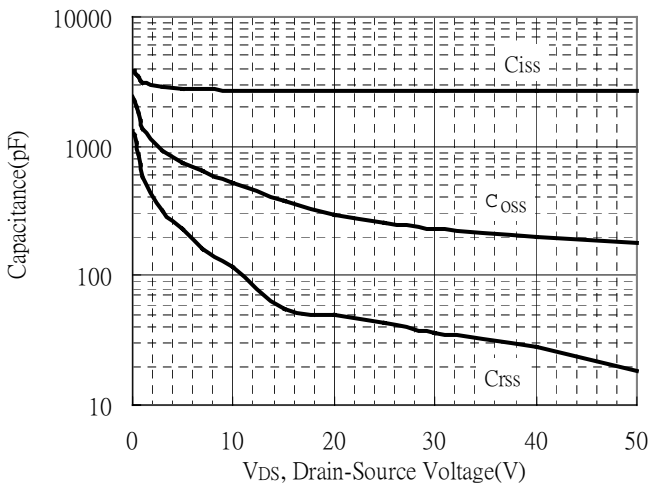
Static Drain-Source On-State Resistance vs Gate-Source Voltage



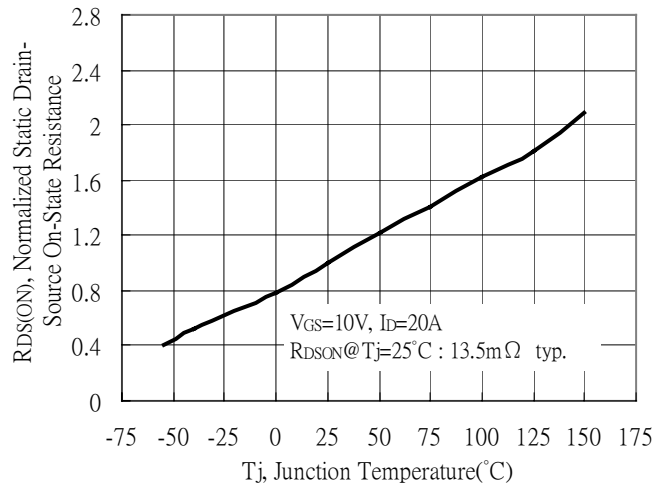
Reverse Drain Current vs Source-Drain Voltage



Capacitance vs Drain-to-Source Voltage



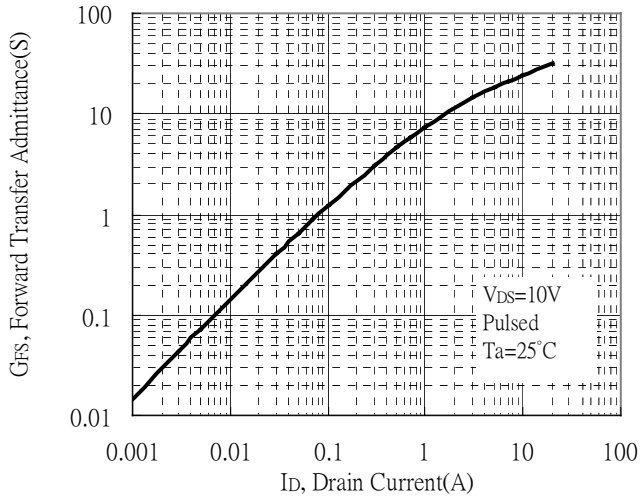
Drain-Source On-State Resistance vs Junction Teperature



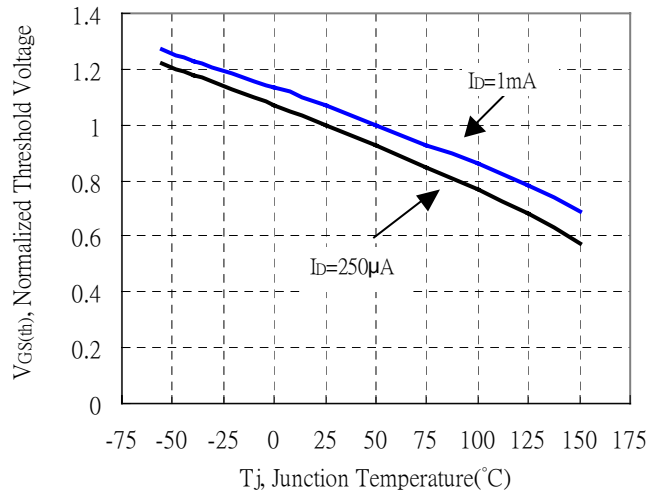


Typical Characteristics(Cont.)

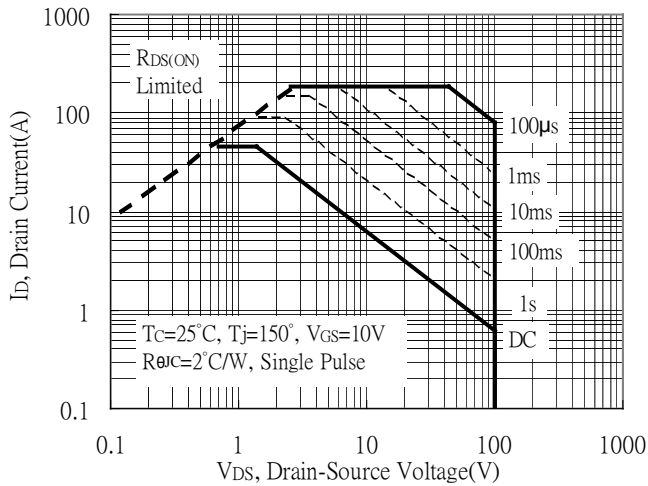
Forward Transfer Admittance vs Drain Current



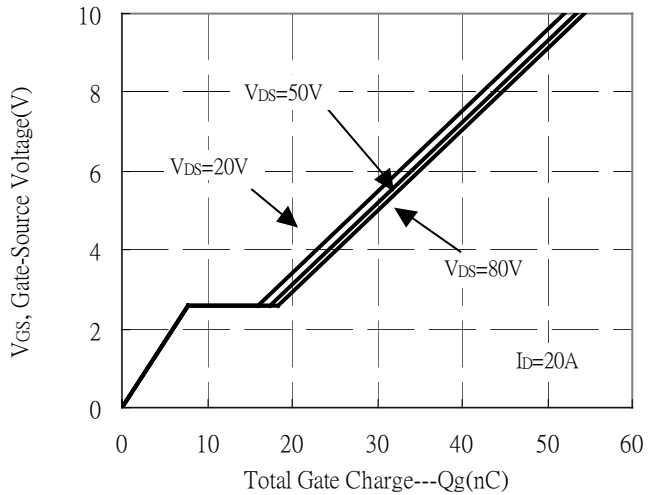
Normalized Threshold Voltage vs Junction Temperature



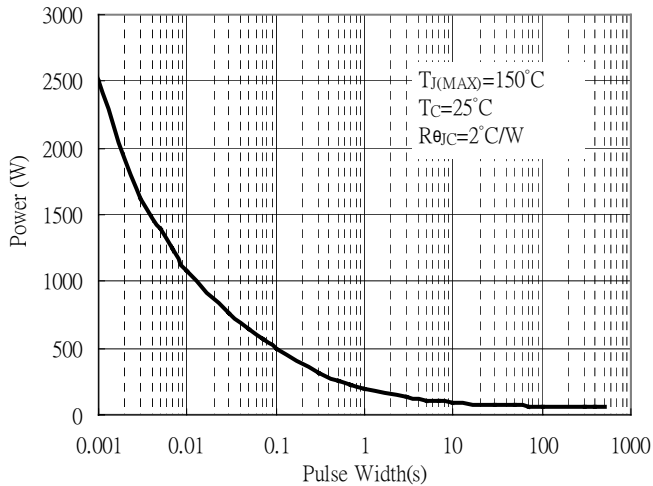
Maximum Safe Operating Area



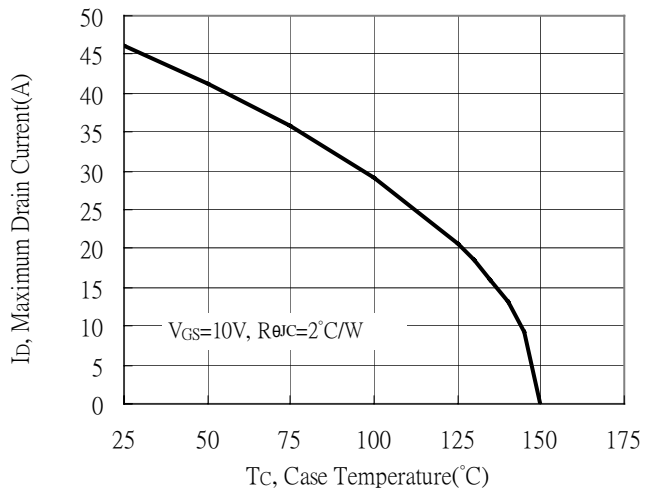
Gate Charge Characteristics



Single Pulse Maximum Power Dissipation

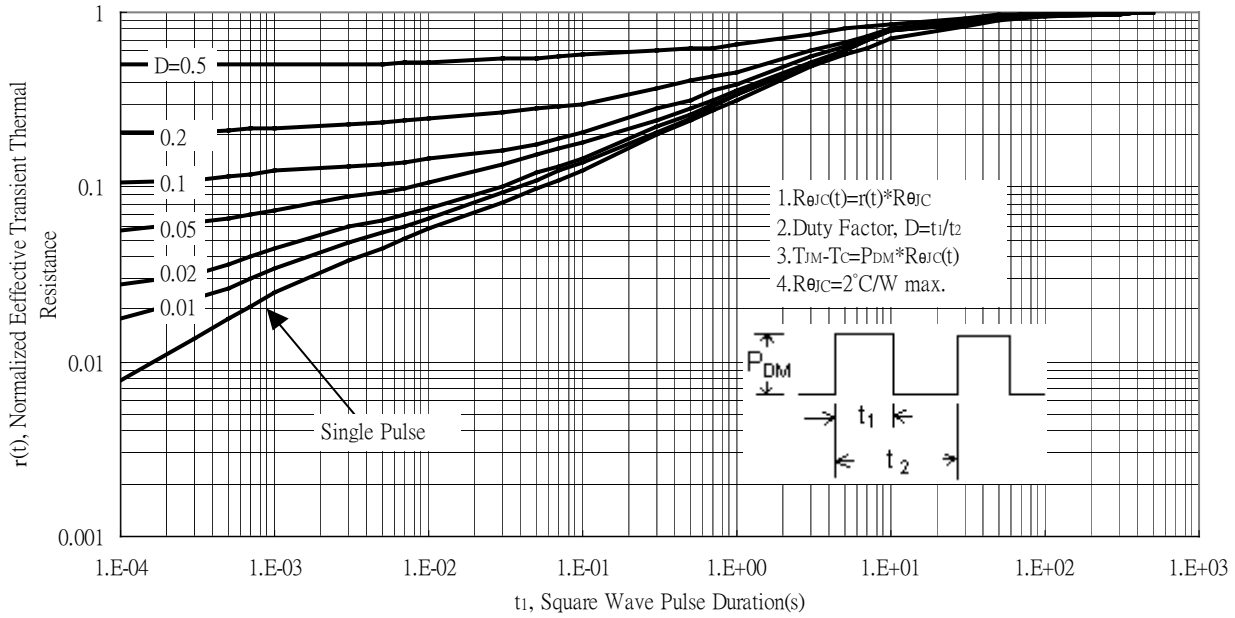


Maximum Drain Current vs Case Temperature



Typical Characteristics(Cont.)

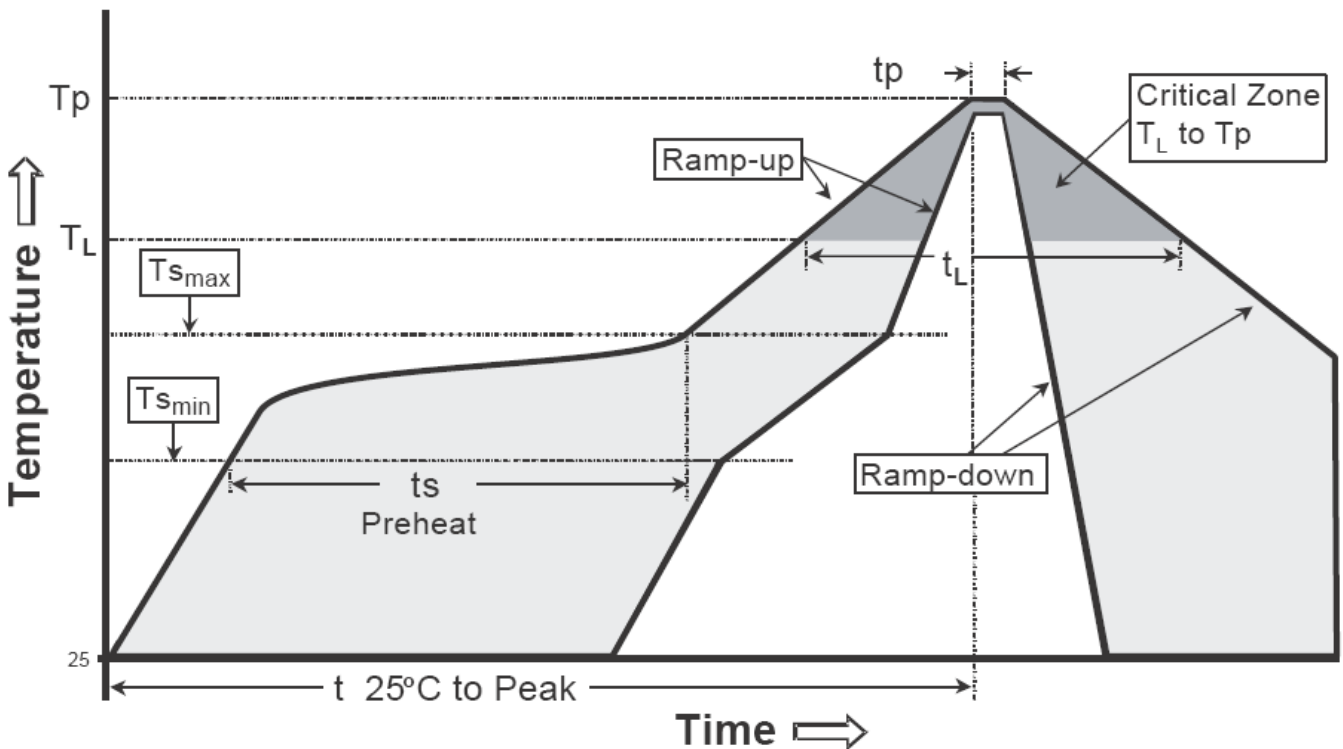
Transient Thermal Response Curves



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

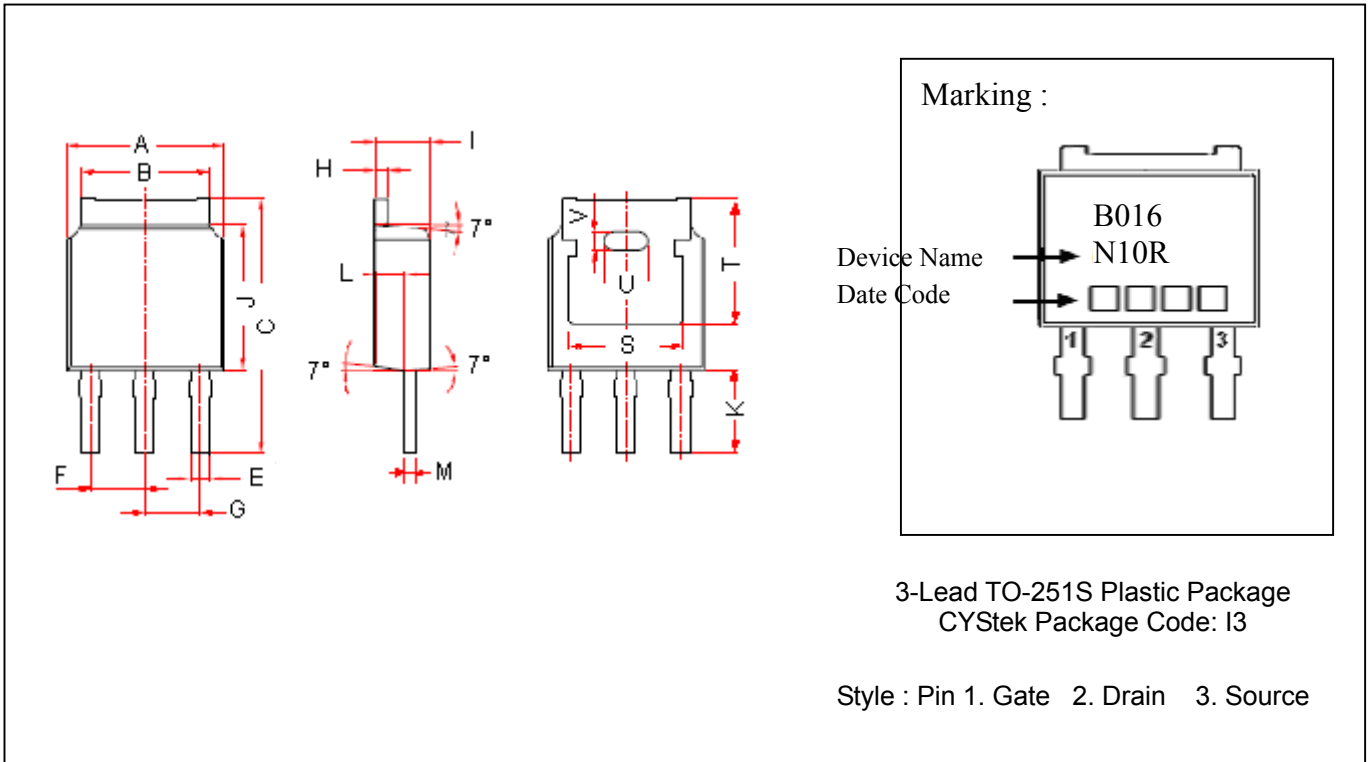
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T _{smax} to T _p)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T _{s min})	100°C	150°C
-Temperature Max(T _{s max})	150°C	200°C
-Time(t _{s min} to t _{s max})	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T _L)	183°C	217°C
- Time (t _L)	60-150 seconds	60-150 seconds
Peak Temperature(T _P)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

TO-251S Dimension



Marking :

Device Name → B016
 N10R
 Date Code → □ □ □ □

3-Lead TO-251S Plastic Package
 CYStek Package Code: I3

Style : Pin 1. Gate 2. Drain 3. Source

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.2559	0.2638	6.50	6.70	J	0.2362	0.2441	6.00	6.20
B	0.2020	0.2126	5.13	5.46	K	0.1299	0.1457	3.30	3.70
C	0.4094	0.4331	10.40	11.00	L	0.0358	0.0437	0.91	1.11
E	0.0280	0.0319	0.71	0.81	M	0.0181	0.0220	0.46	0.56
F	0.0858	0.0941	2.18	2.39	S	0.1902	REF	4.83	REF
G	0.0858	0.0941	2.18	2.39	T	0.2106	REF	5.35	REF
H	0.0181	0.0220	0.46	0.56	U	0.0701	REF	1.78	REF
I	0.0902	0.0937	2.29	2.38	V	0.0299	REF	0.76	REF

Notes: 1. Controlling dimension: inch.
 2. Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3. If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0

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